Notice of References Cited

| Application/Control No. 10/735,290 | Applicant(s)/Patent Under Reexamination NAGAI ET AL. | |
|---------------------------------------|--|-------------|
| Examiner | Art Unit | |
| Michael Y. Won | 2155 | Page 1 of 2 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|----|---|--|-----------------|------------------------|----------------|
| * | Α | US-4,962,532 | 10-1990 | Kasiraj et al. | 726/6 |
| * | В | US-6,230,186 | 05-2001 | Yaker, Rhoda | 709/206 |
| * | С | US-6,324,569 | 11-2001 | Ogilvie et al. | 709/206 |
| * | D | US-2002/0023138 | 02-2002 | Quine et al. | 709/206 |
| * | Е | US-2002/0087641 | 07-2002 | Levosky, Michael P. | 709/206 |
| * | F | US-2002/0103935 | 08-2002 | Fishman et al. | 709/246 |
| * | G | US-2002/0129275 | 09-2002 | Decuir, Joseph Charles | 713/201 |
| * | Н | US-2003/0131060 | 07-2003 | Hartselle et al. | 709/206 |
| * | 1 | US-2003/0233410 | 12-2003 | Gusler et al. | 709/206 |
| .* | J | US-2004/0003030 | 01-2004 | Abe, Masaaki | 709/203 |
| * | к | US-2004/0010552 | 01-2004 | Keohane et al. | 709/206 |
| * | L | US-2004/0010552 | 01-2004 | Keohane et al. | 709/206 |
| * | М | US-2004/0019644 | 01-2004 | Fellenstein et al. | 709/206 |

FOREIGN PATENT DOCUMENTS

| *. | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|----|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | 0 | * | | | - | |
| | Р | | | | | |
| | σ | | | | | |
| | R | | | | | |
| | S | | | | | |
| | Т | , | | | | |

NON-PATENT DOCUMENTS

| | NON-FAILNI DOCUMENTO | | | | | |
|---|----------------------|---|--|--|--|--|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) | | | | |
| | υ | | | | | |
| | V | | | | | |
| | w | | | | | |
| | x | | | | | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination NAGAI ET AL. Examiner | Art Unit | Page 2 of 2

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------------|----------------------|
| * | Α | US-6,701,347 | 03-2004 | Ogilvie, John W. L. | . 709/206 |
| * | В | US-2004/0064734 | 04-2004 | Ehrlich, Julian | 713/201 |
| * | O | US-6,721,784 | 04-2004 | Leonard et al. | 709/206 ⁻ |
| * | D | US-7,032,011 | 04-2006 | Woodard et al. | 709/220 |
| * | E | US-7,228,334 | 06-2007 | Jordan, Jr., Royce D. | 709/206 |
| | F | US- | | | |
| | G | US- | | | |
| | Н | US- | | · | |
| | ı | US- | | · · | |
| | 7 | US- | | | |
| | К | US- | | | |
| | L | US- | | | |
| | М | US- | | , . | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | 0 | | | • | · | |
| | Р | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | s | | | | | |
| | Т | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | w | |
| | x | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.